Notice of References Cited Examiner Art Unit

Application/Control No.

Reexamination KWON ET AL. 09/667,006 Page 1 of 1 Thoi V Duong 2871

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,471,327 A	11-1995	Tedesco et al.	359/15
*	В	US-6,141,123 A	10-2000	Nakashima et al.	359/3
*	С	US-5,629,784 A	05-1997	Abileah et al.	349/112
.[D	US-6,075,581 A	06-2000	Shirochi, Yoshiki	349/112
	Е	US-			
	F	US-			
	G	US-		4 100	
<u>. </u>	Н	US-			
	1	US-			
	J	US-			,
	K	US-	*		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	S.					
	Т					

NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.